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InGaIN Metal-IN Solar Cell: optimized efficiency and fabrication tolerance

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Choosing the Indium Gallium Nitride (InGaIN) ternary alloy for thin films solar cells might yield high benefits concerning efficiency and reliability, because its bandgap can be tuned through the Indium composition and radiations have little destructive effect on it. It may also reveal challenges because good quality p-doped InGaIN layers are difficult to elaborate. In this letter, a new design for an InGaIN thin film solar cell is optimized, where the p-layer of a PIN structure is replaced by a Schottky contact, leading to a Metal-IN (MIN) structure. With a simulated efficiency of 19.8%, the MIN structure performs better than the previously studied Schottky structure, while increasing its fabrication tolerance and thus functional reliability.

Owing to its good tolerance to radiations [1], its high light absorption [2, 3] and its Indium–composition–tuned bandgap [4, 5], the Indium Gallium Nitride (InGaIN) ternary alloy is a good candidate for high–efficiency–high–reliability solar cells able to operate in harsh environments.

Unfortunately, InGaIN p-doping is still a challenge, owing to InGaIN residual n-doping [6], the lack of dedicated acceptors [7] and the complex fabrication process itself [8, 9]. To these drawbacks can be added the uneasy fabrication of ohmic contacts [4] and the difficulty to grow the high-quality-high-Indium-content thin films [10] which would be needed to cover the whole solar spectrum. These drawbacks still prevent InGaIN solar cells to be competitive with other well established III-V and silicon technologies [11].

In this letter, a new design for an InGaIN thin film solar cell is optimized, where the InGaIN p-doped layer is removed and replaced by a Schottky contact, lifting one of the above mentioned drawbacks. A set of realistic physical models based on actual measurements is used to simulate and optimize its behavior and performance using mathematically rigorous multi-criteria optimization methods, aiming to show that both efficiency and fabrication tolerances are better than the previously described simple InGaIN Schottky solar cell [12].

The material dependent parameters used in this study have been determined for GaN and InN binaries, either from experimental work or ab initio calculations [13, 14]. A review of their values is given in Table I. The values for InGaIN were linearly interpolated in between the GaN and InN binaries, except for the bandgap $E_g$ and the electronic affinity $\chi$ where the modified Vegard Law was used, with a bowing factor $b = 1.43$ eV for the bandgap and $b = 0.8$ eV for the affinity, respectively [14, 15].

In the InGaIN III-Nitride semiconductor, the transport equations for electrons and holes can be derived from a drift-diffusion model, provided both carriers mobilities are deduced from temperature and doping using the Caughey-Thomas expressions [16]

$$\mu_m = \frac{\mu_{m1}(T)}{300} + \mu_{m2}(T) \left( \frac{T}{300} \right) \beta_n - \mu_{m1}(T) \left( \frac{T}{300} \right)^2 \frac{\alpha_n}{1 + \left( \frac{N}{N_{crit}} \right)^{\gamma_p}},$$

in which $m$ is either $n$ or $p$, $\mu_n$, $\beta_n$, $\gamma_n$, $\alpha_p$, $\beta_p$ and $\gamma_p$ have been estimated to 1.

<table>
<thead>
<tr>
<th></th>
<th>$E_g$ (eV)</th>
<th>$\chi$ (eV)</th>
<th>$N_n$ (cm$^{-3}$)</th>
<th>$N_p$ (cm$^{-3}$)</th>
<th>$\varepsilon$</th>
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<tbody>
<tr>
<td>GaN</td>
<td>3.42</td>
<td>4.1</td>
<td>$2.3 \times 10^{18}$</td>
<td>$4.6 \times 10^{16}$</td>
<td>8.9</td>
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<tr>
<td>InN</td>
<td>0.7</td>
<td>5.6</td>
<td>$9.1 \times 10^{17}$</td>
<td>$5.3 \times 10^{15}$</td>
<td>15.3</td>
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</table>

(a) Data from refs [14].

<table>
<thead>
<tr>
<th></th>
<th>$\mu_n^1$ (cm$^2$/Vs)</th>
<th>$\mu_n^2$ (cm$^2$/Vs)</th>
<th>$\delta_n$</th>
<th>$N_{ncrit}$ (cm$^{-3}$)</th>
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</thead>
<tbody>
<tr>
<td>GaN</td>
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<td>1460</td>
<td>0.71</td>
<td>$7.7 \times 10^{16}$</td>
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<td>10885</td>
<td>0.7439</td>
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(b) Data from refs [13, 21].

<table>
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<th>$\beta_p^2$ (cm$^2$/Vs)</th>
<th>$\delta_p$</th>
<th>$N_{pcrit}$ (cm$^{-3}$)</th>
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<td>2.0</td>
<td>$1.0 \times 10^{18}$</td>
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<tr>
<td>InN</td>
<td>3.0</td>
<td>340</td>
<td>2.0</td>
<td>$8.0 \times 10^{17}$</td>
</tr>
</tbody>
</table>

(c) Data from ref [14].

<table>
<thead>
<tr>
<th></th>
<th>$\alpha_n$ (cm$^{-1}$)</th>
<th>$\alpha_p$ (cm$^{-1}$)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>$10^6$</td>
<td>$10^6$</td>
</tr>
</tbody>
</table>

TABLE I. Experimental or ab initio data used in the simulations. Owing to the absence of any experimental data, $\alpha_n$, $\beta_n$, $\gamma_n$, $\alpha_p$, $\beta_p$ and $\gamma_p$ have been estimated to 1.

To increase the carrier transport modeling precision above the mere change in the mobility, were included in the model the bandgap narrowing effect [17], as well as the Shockley–Read–Hall (SRH) [18] and the direct and Auger recombination models using Fermi statistics [19]. To complete the picture, the holes and electrons lifetime was taken equal to 1ns in InGaIN.

Light absorption in InGaIN is modeled for the whole solar spectrum and for all $x$ Indium compositions using a previously proposed phenomenological model [14] as

$$\alpha(x) = 10^6 \varepsilon (x) \sqrt{C (E_{ph} - E_g) + D (E_{ph} - E_g)^2},$$

where

$$\varepsilon(x) = 10^6 \sqrt{C (E_{ph} - E_g) + D (E_{ph} - E_g)^2},$$

where

$C$ and $D$ are the complex recombination coefficients.

$a$ This journal article is written on the basis of the research results presented during the 2nd Edition Nanotech France 2016 that was held from 1st to 3rd June 2016 in Paris-France.
where $E_{\text{ph}}$ is the incoming photon energy, $E_g$ is the material bandgap at a given Indium composition, $C$ and $D$ are empirical parameters depending on the Indium composition. They are modeled from experimental measurements\cite{14} summarized in Table II. Their dependence on the Indium composition $x$ is approximated by a polynomial fit, of the 4th degree for the former, and quadratic for the latter:

$$C = 3.525 - 18.29x + 40.22x^2 - 37.52x^3 + 12.77x^4$$
$$D = -0.6651 + 3.616x - 2.460x^2$$

The refraction index is modeled through the Adachi model [22] defined for InGaN and for a given photon energy as

$$n(E_{\text{ph}}) = \sqrt{\frac{A}{E_{\text{ph}}}} \left[ 2 - \sqrt{1 + \frac{E_{\text{ph}}}{E_g} - \sqrt{1 - \frac{E_{\text{ph}}}{E_g}}} + B \right],$$

where $A$ and $B$ are also empirical parameters depending on the Indium composition. They have been experimentally measured [13, 14] for GaN ($A_{\text{GaN}} = 9.31$ and $B_{\text{GaN}} = 3.03$) and InN ($A_{\text{InN}} = 13.55$ and $B_{\text{InN}} = 2.05$) and are linearly interpolated for InGaN.

Finally, a ASTM-G75-03 solar spectrum taken from the National Renewable Energy Laboratory database [23] was shown on the solar cell.

The devices were then simulated in the framework of the above mentioned drift-diffusion model using the Atlas$^\text{®}$ device simulation tool from Silvaco$^\text{®}$, in which the above described detailed physical model was implemented. Solving the coupled drift-diffusion equations in two dimensions allowed the calculation of the solar cell performances, along with its spectral response, I-V characteristics, electric field and potential distributions...

The mathematically rigorous L-BFGS-B quasi-Newton optimization method [24] was used to find the optimum efficiency with respect to a given set of parameters; work done through a Python package that we developed in the SAGE$^\text{®}$ interface to the SciPy [26, 27] optimizers, using the Atlas$^\text{®}$ simulator as the backend engine.

Unlike the n-type doping, relatively easy for the InGaN alloy, the p-type doping is still challenging to achieve, owing mainly to the unintentional n-doping (UID) and the lack of adequate acceptors [7]. The MIN solar cell was optimized with respect to its most important parameters: $L_i$ and $L_n$, the thicknesses of the I and N layers respectively, $N_i$ and $N_n$, the doping levels of the $I$ and $N$ layers respectively, the Indium composition $x$ and the metal workfunction $W_f$. The optimal values for all these parameters have been sought within a physically and technologically meaningful interval. The resulting optimum efficiency is reported in table III, along with the associated photovoltaic parameters as well as the corresponding parameters and their tolerance range. The results corresponding to the previously reported Schottky structure [12] are provided for comparison purposes. The maximum MIN cell efficiency is found to be 19.8%, comparable to the highest efficiencies reported for the thin films solar cells [28].

Figure 2 shows the current-voltage characteristics of the optimal $MIN$ solar cell, the Schottky one still being shown for comparison purposes. We observe that the $MIN$ structure has a higher $J_{SC}$ compared to the Schottky structure, but a lower $V_{OC}$, associated to a higher overall efficiency. This behavior stems from the change in the bandgap induced by the Indium composition variation.

Figure 3 shows the variation of the photovoltaic (PV) efficiency as a function of the i-layer doping (i-doping) for various i-thicknesses, the other parameters being at their optimal value. The optimal i-doping value is about 6.
higher dopings quickly and drastically reduces the PV efficiency. Figure 4 shows the External Quantum Efficiency (EQE) spectra of the optimal MIN solar cell for an i-layer doping ranging from $1.0 \times 10^{14} \text{cm}^{-3}$ to $1.0 \times 10^{18} \text{cm}^{-3}$. As can be seen from figure 4, the optimal doping of $6.1 \times 10^{16} \text{cm}^{-3}$ does not yield the optimal EQE. Indeed, an optimum EQE corresponds to an optimal photocurrent, while an increase in the i-doping also implies here a raise in the solar cell voltage. This results in a trade-off between increasing voltage and decreasing photocurrent, yielding an intermediate i-doping optimum. At this optimal i-doping, the EQE value is close to its maximum value for a large fraction of the solar spectrum.

The ultimate goal of this work is the actual device solar cell fabrication. That is the reason why the simulations and optimizations have been conducted with actually measured parameters and realistic physical models. To complete the study on actual fabrication, we have conducted a tolerance analysis on the optimal parameters that were found. We have thus defined a tolerance range, which is the range of values of a given parameter for which the efficiency $\eta$ remains above 90% of its maximum value. The tolerance range is shown on table III, just below the optimal value. For instance, for the MIN structure, the efficiency value remains between 17.8% and 19.2% for an i-layer doping $N_i$ varying between $1.0 \times 10^{14} \text{cm}^{-3}$ and $1.0 \times 10^{17} \text{cm}^{-3}$, the other parameters remaining at their optimal values.

The MIN structure tolerance ranges, wider than that of the Schottky structure [12], allow to remove another drawback of solar cell InGaN technology, which is the difficult realization of ohmic contacts. Indeed, the wide tolerance range on the n-doping $[1.8 \times 10^{16} - 1.0 \times 10^{19}] \text{cm}^{-3}$ allows to design heavily doped n-layers to elaborate low resistance ohmic contacts on InGaN without noticeably impacting the photovoltaic performances.

Finally, and as hinted previously, we attempt to address an-
TABLE IV. The dominating deep-level defect parameters in InGaN as experimentally measured and reported in [29, 30] for Indium composition $x = 0.09$, in [31] for $x = 0.13$ and in [32] for $x = 0.20$. The defect energy is measured relative to the conduction band edge.

<table>
<thead>
<tr>
<th>Indium Composition $x$</th>
<th>Defect energy ($eV$)</th>
<th>Concentration ($cm^{-3}$)</th>
</tr>
</thead>
<tbody>
<tr>
<td>0.09</td>
<td>3.05</td>
<td>$2.7 \times 10^{16}$</td>
</tr>
<tr>
<td>0.13</td>
<td>2.76</td>
<td>$8.5 \times 10^{15}$</td>
</tr>
<tr>
<td>0.20</td>
<td>2.50</td>
<td>$6.1 \times 10^{15}$</td>
</tr>
</tbody>
</table>

FIG. 5. InGaN MIN solar cell photovoltaic efficiency variation with defect density for two Gaussian distributions. The cell parameters are fixed to their optimal values shown in table III.

other of the main challenges preventing the development of high efficiency InGaN solar cell, which is the high defect density usually present in the grown thin films [10]. In order to study the impact these defects may have on the here proposed MIN solar cell performances, we included in the simulation the dominating deep defects, which have been experimentally studied in literature using the well known Deep Level (Transient & Optical) Spectroscopy (DLTS and DLOS), the Steady-State PhotoCapacitance (SSPC) and the Lighted Capacitance-Voltage (LCV) techniques [29–32].

We have thus optimized a new MIN solar cell structure using a rigorous numerical optimization approach and most realistic parameters and physical models. An optimal efficiency of 19.8% was found, associated to wide tolerance ranges, lifting two of the major drawbacks of InGaN technology for solar cells. Indeed, on the one hand, the Schottky contact has removed the need for p-doping, yielding a MIN solar cell with an efficiency comparable to that of the highest efficiencies reported for the thin films structures. On the other hand, the MIN structure wide tolerances have facilitated the design of low resistance ohmic contacts and the growth defects management.

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